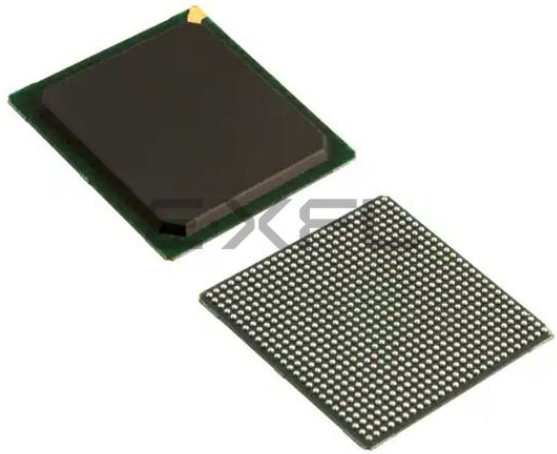

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Details	
Product Status	Active
Number of LABs/CLBs	2816
Number of Logic Elements/Cells	25344
Total RAM Bits	589824
Number of I/O	502
Number of Gates	1400000
Voltage - Supply	1.14V ~ 1.26V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 85°C (TJ)
Package / Case	676-BGA
Supplier Device Package	676-FBGA (27x27)
Purchase URL	https://www.e-xfl.com/product-detail/xilinx/xc3s1400an-4fgg676c

Ordering Information

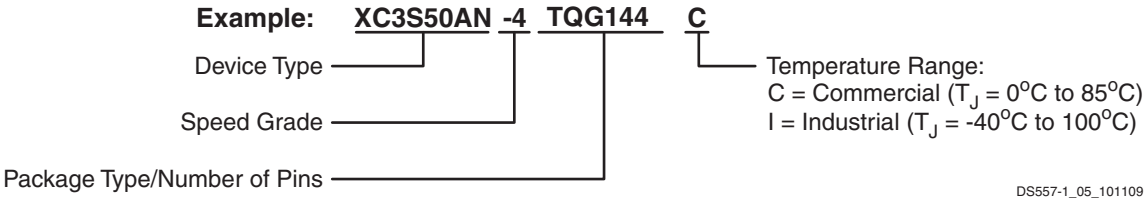

Figure 5: **Device Numbering Format**

Device	Speed Grade		Package Type / Number of Pins		Temperature Range (T_J)	
XC3S50AN	-4	Standard Performance	TQ144/ TQG144	144-pin Thin Quad Flat Pack (TQFP)	C	Commercial (0°C to 85°C)
XC3S200AN	-5	High Performance(1)	FT256/ FTG256	256-ball Fine-Pitch Thin Ball Grid Array (FTBGA)	I	Industrial (–40°C to 100°C)
XC3S400AN			FG400/ FGG400	400-ball Fine-Pitch Ball Grid Array (FBGA)		
XC3S700AN			FG484/ FGG484	484-ball Fine-Pitch Ball Grid Array (FBGA)		
XC3S1400AN			FG676/ FGG676	676-ball Fine-Pitch Ball Grid Array (FBGA)		

Notes:

1. The -5 speed grade is exclusively available in the Commercial temperature range.
2. See Table 4 and Table 5 for available package combinations.

Revision History

The following table shows the revision history for this document.

Date	Version	Revision
02/26/07	1.0	Initial release.
08/16/07	2.0	Updated for Production release of initial device.
09/12/07	2.0.1	Noted that only dual-mark devices are guaranteed for both -4I and -5C.
12/12/07	3.0	Updated to Production status with Production release of final family member, XC3S50AN. Noted that non-Pb-free packages may be available for selected devices.
06/02/08	3.1	Minor updates.
11/19/09	3.2	Updated document throughout to reflect availability of Pb package options. Added references to the Extended Spartan-3A family. Removed table note 2 from Table 2. In Table 4, added Pb packages, added table note 4, and updated table note 2. Added Table 5.
12/02/10	4.0	Updated Notice of Disclaimer.
04/01/11	4.1	In Table 2, revised the Maximum Differential I/O Pairs and Maximum User I/O values for the XC3S50AN. In Table 4, added packages to the XC3S50AN, XC3S400AN, and XC3S1400AN. Updated Pb and Pb-Free Packaging section and Table 5 to include the new device/package combinations for the XC3S50AN, XC3S400AN, and XC3S1400AN.

DC Electrical Characteristics

In this section, specifications can be designated as Advance, Preliminary, or Production. These terms are defined as follows:

Advance: Initial estimates are based on simulation, early characterization, and/or extrapolation from the characteristics of other families. Values are subject to change. Use as estimates, not for production.

Preliminary: Based on characterization. Further changes are not expected.

Production: These specifications are approved once the silicon has been characterized over numerous production lots. Parameter values are considered stable with no future changes expected.

All parameter limits are representative of worst-case supply voltage and junction temperature conditions. **Unless otherwise noted, the published parameter values apply to all Spartan®-3AN devices. AC and DC characteristics are specified using the same numbers for both commercial and industrial grades.**

Absolute Maximum Ratings

Stresses beyond those listed under Table 6: Absolute Maximum Ratings might cause permanent damage to the device. These are stress ratings only; functional operation of the device at these or any other conditions beyond those listed under the Recommended Operating Conditions is not implied. Exposure to absolute maximum conditions for extended periods of time adversely affects device reliability.

Table 6: **Absolute Maximum Ratings**

Symbol	Description	Conditions	Min	Max	Units
V_{CCINT}	Internal supply voltage		–0.5	1.32	V
V_{CCAUX}	Auxiliary supply voltage		–0.5	3.75	V
V_{CCO}	Output driver supply voltage		–0.5	3.75	V
V_{REF}	Input reference voltage		–0.5	V_{CCO} + 0.5	V
V_{IN}	Voltage applied to all User I/O pins and dual-purpose pins	Driver in a high-impedance state	–0.95	4.6	V
	Voltage applied to all Dedicated pins		–0.5	4.6	V
I_{IK}	Input clamp current per I/O pin	$-0.5V < V_{IN} < (V_{CCO} + 0.5V)$(1)	–	±100	mA
V_{ESD}	Electrostatic Discharge Voltage	Human body model	–	±2000	V
		Charged device model	–	±500	V
		Machine model	–	±200	V
T_J	Junction temperature		–	125	°C
T_{STG}	Storage temperature		–65	150	°C

Notes:

1. Upper clamp applies only when using PCI IOSTANDARDs.
1. For soldering guidelines, see UG112: Device Package User Guide and XAPP427: Implementation and Solder Reflow Guidelines for Pb-Free Packages.

Quiescent Current Requirements

Table 12: **Spartan-3AN FPGA Quiescent Supply Current Characteristics**

Symbol	Description	Device	Typical(2)	Commercial Maximum(2)	Industrial Maximum(2)	Units
I_{CCINTQ}	Quiescent V_{CCINT} supply current	XC3S50AN	2	20	30	mA
		XC3S200AN	7	50	70	mA
		XC3S400AN	10	85	125	mA
		XC3S700AN	13	120	185	mA
		XC3S1400AN	24	220	310	mA
I_{CCOQ}	Quiescent V_{CCO} supply current	XC3S50AN	0.2	2	3	mA
		XC3S200AN	0.2	2	3	mA
		XC3S400AN	0.3	3	4	mA
		XC3S700AN	0.3	3	4	mA
		XC3S1400AN	0.3	3	4	mA
I_{CCAUXQ}	Quiescent V_{CCAUX} supply current	XC3S50AN	3.1	8.1	10.1	mA
		XC3S200AN	5.1	12.1	15.1	mA
		XC3S400AN	5.1	18.1	24.1	mA
		XC3S700AN	6.1	28.1	34.1	mA
		XC3S1400AN	10.1	50.1	58.1	mA

Notes:

1. The numbers in this table are based on the conditions set forth in Table 10.
2. Quiescent supply current is measured with all I/O drivers in a high-impedance state and with all pull-up/pull-down resistors at the I/O pads disabled. The internal SPI Flash is deselected (CSB = High); the internal SPI Flash current is consumed on the V_{CCAUX} supply rail. Typical values are characterized using typical devices at room temperature (T_J of 25°C at V_{CCINT} = 1.2V, V_{CCO} = 3.3V, and V_{CCAUX} = 3.3V). The maximum limits are tested for each device at the respective maximum specified junction temperature and at maximum voltage limits with V_{CCINT} = 1.26V, V_{CCO} = 3.6V, and V_{CCAUX} = 3.6V. The FPGA is programmed with a “blank” configuration data file (that is, a design with no functional elements instantiated). For conditions other than those described above (for example, a design including functional elements), measured quiescent current levels will be different than the values in the table.
3. There are two recommended ways to estimate the total power consumption (quiescent plus dynamic) for a specific design: a) The Spartan-3AN FPGA XPower Estimator provides quick, approximate, typical estimates, and does not require a netlist of the design, and b) XPower Analyzer uses a netlist as input to provide maximum estimates as well as more accurate typical estimates. For more information on power for the In-System Flash memory, see the Power Management chapter of UG333.
4. The maximum numbers in this table indicate the minimum current each power rail requires in order for the FPGA to power-on successfully.
5. For information on the power-saving Suspend mode, see XAPP480: *Using Suspend Mode in Spartan-3 Generation FPGAs*. Suspend mode typically saves 40% total power consumption compared to quiescent current.

Differential I/O Standards

Differential Input Pairs

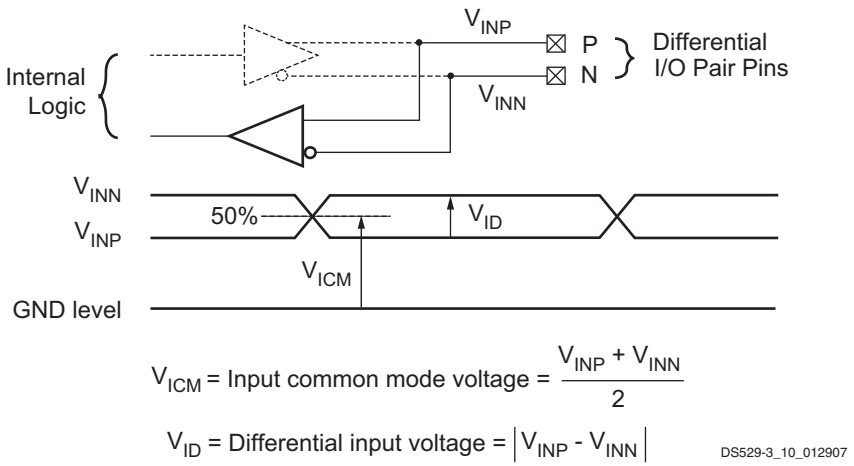

Figure 6: **Differential Input Voltages**

Table 15: **Recommended Operating Conditions for User I/Os Using Differential Signal Standards**

IOSTANDARD Attribute	V_{CCO} for Drivers[1]			V_{ID}			V_{ICM}[2]		
	Min (V)	Nom (V)	Max (V)	Min (mV)	Nom (mV)	Max (mV)	Min (V)	Nom (V)	Max (V)
LVDS_25[3]	2.25	2.5	2.75	100	350	600	0.3	1.25	2.35
LVDS_33[3]	3.0	3.3	3.6	100	350	600	0.3	1.25	2.35
BLVDS_25[4]	2.25	2.5	2.75	100	300	–	0.3	1.3	2.35
MINI_LVDS_25[3]	2.25	2.5	2.75	200	–	600	0.3	1.2	1.95
MINI_LVDS_33[3]	3.0	3.3	3.6	200	–	600	0.3	1.2	1.95
LVPECL_25[5]	Inputs Only			100	800	1000	0.3	1.2	1.95
LVPECL_33[5]	Inputs Only			100	800	1000	0.3	1.2	2.8[6]
RSDS_25[3]	2.25	2.5	2.75	100	200	–	0.3	1.2	1.5
RSDS_33[3]	3.0	3.3	3.6	100	200	–	0.3	1.2	1.5
TMDS_33[3,4,7]	3.14	3.3	3.47	150	–	1200	2.7	–	3.23
PPDS_25[3]	2.25	2.5	2.75	100	–	400	0.2	–	2.3
PPDS_33[3]	3.0	3.3	3.6	100	–	400	0.2	–	2.3
DIFF_HSTL_I_18[8]	1.7	1.8	1.9	100	–	–	0.8	–	1.1
DIFF_HSTL_II_18[8,9]	1.7	1.8	1.9	100	–	–	0.8	–	1.1
DIFF_HSTL_III_18[8]	1.7	1.8	1.9	100	–	–	0.8	–	1.1
DIFF_HSTL_I[8]	1.4	1.5	1.6	100	–	–	0.68		0.9
DIFF_HSTL_III[8]	1.4	1.5	1.6	100	–	–	–	0.9	–
DIFF_SSTL18_I[8]	1.7	1.8	1.9	100	–	–	0.7	–	1.1
DIFF_SSTL18_II[8,9]	1.7	1.8	1.9	100	–	–	0.7	–	1.1
DIFF_SSTL2_I[8]	2.3	2.5	2.7	100	–	–	1.0	–	1.5
DIFF_SSTL2_II[8,9]	2.3	2.5	2.7	100	–	–	1.0	–	1.5
DIFF_SSTL3_I[8]	3.0	3.3	3.6	100	–	–	1.1	–	1.9

Table 23: **Setup and Hold Times for the IOB Input Path *(Cont'd)***

Symbol	Description	Conditions	IFD_DELAY_VALUE	Device	Speed Grade		Units
					-5	-4	
					Min	Min	
$T_{IOPICKD}$	Time from the setup of data at the Input pin to the active transition at the ICLK input of the Input Flip-Flop (IFF). The Input Delay is programmed.	LVCMOS25[2]	1	XC3S700AN	1.82	1.95	ns
			2		2.62	2.83	ns
			3		3.32	3.72	ns
			4		3.83	4.31	ns
			5		3.69	4.14	ns
			6		4.60	5.19	ns
			7		5.39	6.10	ns
			8		5.92	6.73	ns
			1	XC3S1400AN	1.79	2.17	ns
			2		2.55	2.92	ns
			3		3.38	3.76	ns
			4		3.75	4.32	ns
			5		3.81	4.19	ns
			6		4.39	5.09	ns
			7		5.16	5.98	ns
			8		5.69	6.57	ns
Hold Times							
T_{IOICKP}	Time from the active transition at the ICLK input of the Input Flip-Flop (IFF) to the point where data must be held at the Input pin. No Input Delay is programmed.	LVCMOS25[3]	0	XC3S50AN	–0.66	–0.64	ns
				XC3S200AN	–0.85	–0.65	ns
				XC3S400AN	–0.42	–0.42	ns
				XC3S700AN	–0.81	–0.67	ns
				XC3S1400AN	–0.71	–0.71	ns
$T_{IOICKPD}$	Time from the active transition at the ICLK input of the Input Flip-Flop (IFF) to the point where data must be held at the Input pin. The Input Delay is programmed.	LVCMOS25[3]	1	XC3S50AN	–0.88	–0.88	ns
			2		–1.33	–1.33	ns
			3		–2.05	–2.05	ns
			4		–2.43	–2.43	ns
			5		–2.34	–2.34	ns
			6		–2.81	–2.81	ns
			7		–3.03	–3.03	ns
			8		–3.83	–3.57	ns
			1	XC3S200AN	–1.51	–1.51	ns
			2		–2.09	–2.09	ns
			3		–2.40	–2.40	ns
			4		–2.68	–2.68	ns
			5		–2.56	–2.56	ns
			6		–2.99	–2.99	ns
			7		–3.29	–3.29	ns
			8		–3.61	–3.61	ns

Table 30: **Test Methods for Timing Measurement at I/Os *(Cont'd)***

Signal Standard (IOSTANDARD)	Inputs			Outputs[2]		Inputs and Outputs
	V_{REF} (V)	V_L (V)	V_H (V)	R_T (Ω)	V_T (V)	V_M (V)
Differential						
LVDS_25	–	V_{ICM} – 0.125	V_{ICM} + 0.125	50	1.2	V_{ICM}
LVDS_33	–	V_{ICM} – 0.125	V_{ICM} + 0.125	50	1.2	V_{ICM}
BLVDS_25	–	V_{ICM} – 0.125	V_{ICM} + 0.125	1M	0	V_{ICM}
MINI_LVDS_25	–	V_{ICM} – 0.125	V_{ICM} + 0.125	50	1.2	V_{ICM}
MINI_LVDS_33	–	V_{ICM} – 0.125	V_{ICM} + 0.125	50	1.2	V_{ICM}
LVPECL_25	–	V_{ICM} – 0.3	V_{ICM} + 0.3	N/A	N/A	V_{ICM}
LVPECL_33	–	V_{ICM} – 0.3	V_{ICM} + 0.3	N/A	N/A	V_{ICM}
RSDS_25	–	V_{ICM} – 0.1	V_{ICM} + 0.1	50	1.2	V_{ICM}
RSDS_33	–	V_{ICM} – 0.1	V_{ICM} + 0.1	50	1.2	V_{ICM}
TMDS_33	–	V_{ICM} – 0.1	V_{ICM} + 0.1	50	3.3	V_{ICM}
PPDS_25	–	V_{ICM} – 0.1	V_{ICM} + 0.1	50	0.8	V_{ICM}
PPDS_33	–	V_{ICM} – 0.1	V_{ICM} + 0.1	50	0.8	V_{ICM}
DIFF_HSTL_I	–	V_{ICM} – 0.5	V_{ICM} + 0.5	50	0.75	V_{ICM}
DIFF_HSTL_III	–	V_{ICM} – 0.5	V_{ICM} + 0.5	50	1.5	V_{ICM}
DIFF_HSTL_I_18	–	V_{ICM} – 0.5	V_{ICM} + 0.5	50	0.9	V_{ICM}
DIFF_HSTL_II_18	–	V_{ICM} – 0.5	V_{ICM} + 0.5	50	0.9	V_{ICM}
DIFF_HSTL_III_18	–	V_{ICM} – 0.5	V_{ICM} + 0.5	50	1.8	V_{ICM}
DIFF_SSTL18_I	–	V_{ICM} – 0.5	V_{ICM} + 0.5	50	0.9	V_{ICM}
DIFF_SSTL18_II	–	V_{ICM} – 0.5	V_{ICM} + 0.5	50	0.9	V_{ICM}
DIFF_SSTL2_I	–	V_{ICM} – 0.5	V_{ICM} + 0.5	50	1.25	V_{ICM}
DIFF_SSTL2_II	–	V_{ICM} – 0.5	V_{ICM} + 0.5	50	1.25	V_{ICM}
DIFF_SSTL3_I	–	V_{ICM} – 0.5	V_{ICM} + 0.5	50	1.5	V_{ICM}
DIFF_SSTL3_II	–	V_{ICM} – 0.5	V_{ICM} + 0.5	50	1.5	V_{ICM}

Notes:

1. Descriptions of the relevant symbols are as follows:
   V_{REF} – The reference voltage for setting the input switching threshold
   V_{ICM} – The common mode input voltage
   V_M – Voltage of measurement point on signal transition
   V_L – Low-level test voltage at Input pin
   V_H – High-level test voltage at Input pin
   R_T – Effective termination resistance, which takes on a value of 1 MΩ when no parallel termination is required
   V_T – Termination voltage
2. The load capacitance (C_L) at the Output pin is 0 pF for all signal standards.
3. According to the PCI specification. For information on PCI IP solutions, see www.xilinx.com/products/design_resources/conn_central/protocols/pci_pcix.htm. The PCIX IOSTANDARD is available and has equivalent characteristics but no PCI-X IP is supported.

The capacitive load (C_L) is connected between the output and GND. *The Output timing for all standards, as published in the speed files and the data sheet, is always based on a C_L value of zero.* High-impedance probes (less than 1 pF) are used for all measurements. Any delay that the test fixture might contribute to test measurements is subtracted from those measurements to produce the final timing numbers as published in the speed files and data sheet.

Table 32: **Recommended Number of Simultaneously Switching Outputs per V_{CCO}-GND Pair**

Signal Standard (IOSTANDARD)			Package Type			
			TQG144		FTG256, FGG400, FGG484, FGG676	
			Top, Bottom Banks 0,2	Left, Right Banks 1,3	Top, Bottom Banks 0,2	Left, Right Banks 1,3
Single-Ended Standards						
LVTTL	Slow	2	20	20	60	60
		4	10	10	41	41
		6	10	10	29	29
		8	6	6	22	22
		12	6	6	13	13
		16	5	5	11	11
		24	4	4	9	9
	Fast	2	10	10	10	10
		4	6	6	6	6
		6	5	5	5	5
		8	3	3	3	3
		12	3	3	3	3
		16	3	3	3	3
		24	2	2	2	2
	QuietIO	2	40	40	80	80
		4	24	24	48	48
		6	20	20	36	36
		8	16	16	27	27
		12	12	12	16	16
		16	9	9	13	13
		24	9	9	12	12

Table 32: **Recommended Number of Simultaneously Switching Outputs per V_{CCO}-GND Pair *(Cont'd)***

Signal Standard (IOSTANDARD)			Package Type			
			TQG144		FTG256, FGG400, FGG484, FGG676	
			Top, Bottom Banks 0,2	Left, Right Banks 1,3	Top, Bottom Banks 0,2	Left, Right Banks 1,3
LVCMOS33	Slow	2	24	24	76	76
		4	14	14	46	46
		6	11	11	27	27
		8	10	10	20	20
		12	9	9	13	13
		16	8	8	10	10
		24	–	8	–	9
	Fast	2	10	10	10	10
		4	8	8	8	8
		6	5	5	5	5
		8	4	4	4	4
		12	4	4	4	4
		16	2	2	2	2
		24	–	2	–	2
	QuietIO	2	36	36	76	76
		4	32	32	46	46
		6	24	24	32	32
		8	16	16	26	26
		12	16	16	18	18
		16	12	12	14	14
		24	–	10	–	10

Table 34: **CLB Distributed RAM Switching Characteristics**

Symbol	Description	Speed Grade				Units
		-5		-4		
		Min	Max	Min	Max	
Clock-to-Output Times						
T_{SHCKO}	Time from the active edge at the CLK input to data appearing on the distributed RAM output	–	1.69	–	2.01	ns
Setup Times						
T_{DS}	Setup time of data at the BX or BY input before the active transition at the CLK input of the distributed RAM	–0.07	–	–0.02	–	ns
T_{AS}	Setup time of the F/G address inputs before the active transition at the CLK input of the distributed RAM	0.18	–	0.36	–	ns
T_{WS}	Setup time of the write enable input before the active transition at the CLK input of the distributed RAM	0.30	–	0.59	–	ns
Hold Times						
T_{DH}	Hold time of the BX and BY data inputs after the active transition at the CLK input of the distributed RAM	0.13	–	0.13	–	ns
T_{AH}, T_{WH}	Hold time of the F/G address inputs or the write enable input after the active transition at the CLK input of the distributed RAM	0.01	–	0.01	–	ns
Clock Pulse Width						
T_{WPH}, T_{WPL}	Minimum High or Low pulse width at CLK input	0.88	–	1.01	–	ns

Notes:

1. The numbers in this table are based on the operating conditions set forth in Table 10.

Table 35: **CLB Shift Register Switching Characteristics**

Symbol	Description	Speed Grade				Units
		-5		-4		
		Min	Max	Min	Max	
Clock-to-Output Times						
T_{REG}	Time from the active edge at the CLK input to data appearing on the shift register output	–	4.11	–	4.82	ns
Setup Times						
T_{SRLDS}	Setup time of data at the BX or BY input before the active transition at the CLK input of the shift register	0.13	–	0.18	–	ns
Hold Times						
T_{SRLDH}	Hold time of the BX or BY data input after the active transition at the CLK input of the shift register	0.16	–	0.16	–	ns
Clock Pulse Width						
T_{WPH}, T_{WPL}	Minimum High or Low pulse width at CLK input	0.90	–	1.01	–	ns

Notes:

1. The numbers in this table are based on the operating conditions set forth in Table 10.

Table 42: **Switching Characteristics for the DFS**

Symbol	Description		Device	Speed Grade				Units
				-5		-4		
				Min	Max	Min	Max	
Output Frequency Ranges								
CLKOUT_FREQ_FX	Frequency for the CLKFX and CLKFX180 outputs		All	5	350	5	320	MHz
Output Clock Jitter (2)(3)								
CLKOUT_PER_JITT_FX	Period jitter at the CLKFX and CLKFX180 outputs.	CLKIN ≤ 20 MHz	All	Typ	Max	Typ	Max	
				Use the Spartan-3A Jitter Calculator: www.xilinx.com/support/documentation/data_sheets/s3a_jitter_calc.zip				ps
		CLKIN > 20 MHz		±[1% of CLKFX period + 100]	±[1% of CLKFX period + 200]	±[1% of CLKFX period + 100]	±[1% of CLKFX period + 200]	ps
Duty Cycle(4)(5)								
CLKOUT_DUTY_CYCLE_FX	Duty cycle precision for the CLKFX and CLKFX180 outputs, including the BUFGMUX and clock tree duty-cycle distortion		All	–	±[1% of CLKFX period + 350]	–	±[1% of CLKFX period + 350]	ps
Phase Alignment(5)								
CLKOUT_PHASE_FX	Phase offset between the DFS CLKFX output and the DLL CLK0 output when both the DFS and DLL are used		All	–	±200	–	±200	ps
CLKOUT_PHASE_FX180	Phase offset between the DFS CLKFX180 output and the DLL CLK0 output when both the DFS and DLL are used		All	–	±[1% of CLKFX period + 200]	–	±[1% of CLKFX period + 200]	ps
Lock Time								
LOCK_FX(2)	The time from deassertion at the DCM's Reset input to the rising transition at its LOCKED output. The DFS asserts LOCKED when the CLKFX and CLKFX180 signals are valid. If using both the DLL and the DFS, use the longer locking time.	5 MHz ≤ F_{CLKIN} ≤ 15 MHz	All	–	5	–	5	ms
		F_{CLKIN} > 15 MHz		–	450	–	450	µs

Notes:

1. The numbers in this table are based on the operating conditions set forth in Table 10 and Table 41.
2. For optimal jitter tolerance and faster lock time, use the CLKIN_PERIOD attribute.
3. Maximum output jitter is characterized within a reasonable noise environment (40 SSOs and 25% CLB switching) on an XC3S1400A FPGA. Output jitter strongly depends on the environment, including the number of SSOs, the output drive strength, CLB utilization, CLB switching activities, switching frequency, power supply and PCB design. The actual maximum output jitter depends on the system application.
4. The CLKFX and CLKFX180 outputs always have an approximate 50% duty cycle.
5. Some duty-cycle and alignment specifications include a percentage of the CLKFX output period. For example, the data sheet specifies a maximum CLKFX jitter of "±[1% of CLKFX period + 200]". Assume the CLKFX output frequency is 100 MHz. The equivalent CLKFX period is 10 ns and 1% of 10 ns is 0.1 ns or 100 ps. According to the data sheet, the maximum jitter is ±[100 ps + 200 ps] = ±300 ps.

Configuration Clock (CCLK) Characteristics

Table 51: **Master Mode CCLK Output Period by *ConfigRate* Option Setting**

Symbol	Description	*ConfigRate* Setting[1]	Temperature Range	Minimum	Maximum	Units
T_{CCLK1}	CCLK clock period by ***ConfigRate*** setting	1 *(power-on value)*	Commercial	1,254	2,500	ns
			Industrial	1,180		ns
T_{CCLK3}		3	Commercial	413	833	ns
			Industrial	390		ns
T_{CCLK6}		6 (*default*)	Commercial	207	417	ns
			Industrial	195		ns
T_{CCLK7}		7	Commercial	178	357	ns
			Industrial	168		ns
T_{CCLK8}		8	Commercial	156	313	ns
			Industrial	147		ns
T_{CCLK10}		10	Commercial	123	250	ns
			Industrial	116		ns
T_{CCLK12}		12	Commercial	103	208	ns
			Industrial	97		ns
T_{CCLK13}		13	Commercial	93	192	ns
			Industrial	88		ns
T_{CCLK17}		17	Commercial	72	147	ns
			Industrial	68		ns
T_{CCLK22}		22	Commercial	54	114	ns
			Industrial	51		ns
T_{CCLK25}		25	Commercial	47	100	ns
			Industrial	45		ns
T_{CCLK27}		27	Commercial	44	93	ns
			Industrial	42		ns
T_{CCLK33}		33	Commercial	36	76	ns
			Industrial	34		ns
T_{CCLK44}		44	Commercial	26	57	ns
			Industrial	25		ns
T_{CCLK50}		50	Commercial	22	50	ns
			Industrial	21		ns
$T_{CCLK100}$		100	Commercial	11.2	25	ns
			Industrial	10.6		ns

Notes:

1. Set the ***ConfigRate*** option value when generating a configuration bitstream.

Table 54: **Slave Mode CCLK Input Low and High Time**

Symbol	Description	Min	Max	Units
T_{SCCL}, T_{SCCH}	CCLK Low and High time	5	∞	ns

Master Serial and Slave Serial Mode Timing

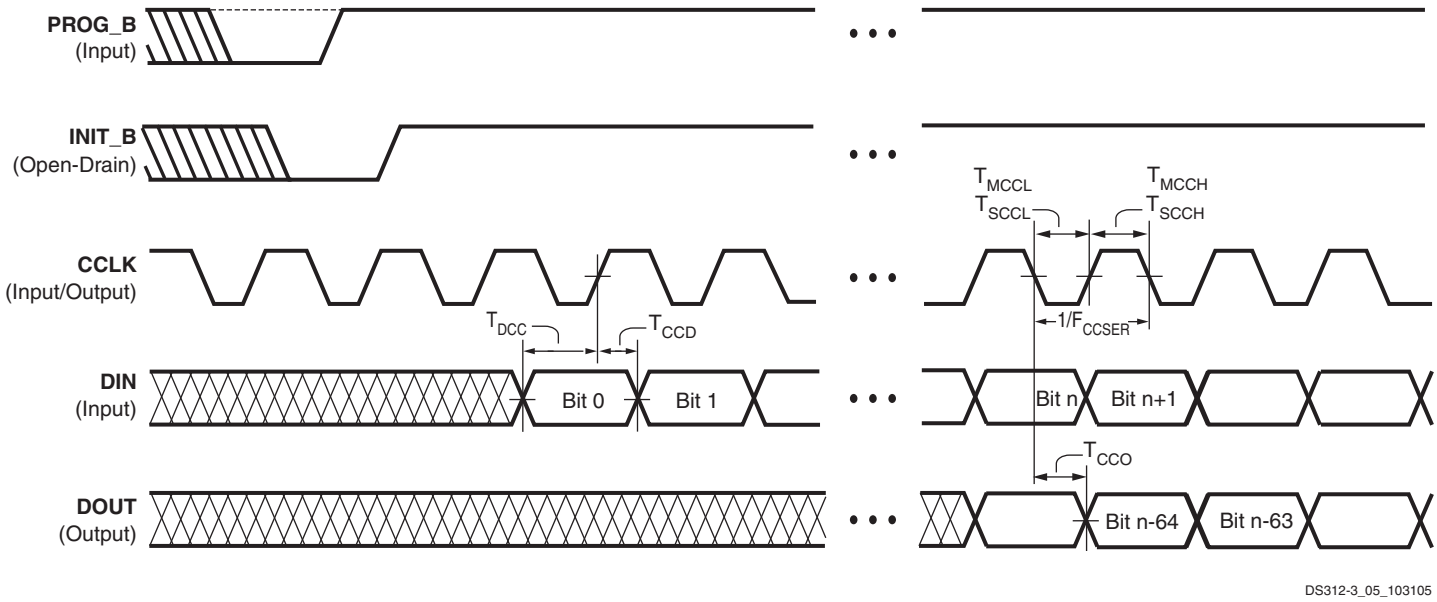

Figure 14: **Waveforms for Master Serial and Slave Serial Configuration**

Table 55: **Timing for the Master Serial and Slave Serial Configuration Modes**

Symbol	Description		Slave/ Master	All Speed Grades		Units
				Min	Max	
Clock-to-Output Times						
T_{CCO}	The time from the falling transition on the CCLK pin to data appearing at the DOUT pin		Both	1.5	10	ns
Setup Times						
T_{DCC}	The time from the setup of data at the DIN pin to the rising transition at the CCLK pin		Both	7	–	ns
Hold Times						
T_{CCD}	The time from the rising transition at the CCLK pin to the point when data is last held at the DIN pin		Master	0	–	ns
			Slave	1.0		
Clock Timing						
T_{CCH}	High pulse width at the CCLK input pin		Master	See Table 53		
			Slave	See Table 54		
T_{CCL}	Low pulse width at the CCLK input pin		Master	See Table 53		
			Slave	See Table 54		
F_{CCSER}	Frequency of the clock signal at the CCLK input pin(2)	No bitstream compression	Slave	0	100	MHz
		With bitstream compression		0	100	MHz

Notes:

1. The numbers in this table are based on the operating conditions set forth in Table 10.
2. For serial configuration with a daisy-chain of multiple FPGAs, the maximum limit is 25 MHz.

Table 61: **Timing for the JTAG[2] Test Access Port**

Symbol	Description		All Speed Grades		Units
			Min	Max	
Clock-to-Output Times					
T_{TCKTDO}	The time from the falling transition on the TCK pin to data appearing at the TDO pin		1.0	11.0	ns
Setup Times					
T_{TDITCK}	The time from the setup of data at the TDI pin to the rising transition at the TCK pin	All devices and functions except those shown below	7.0	–	ns
		Boundary-Scan commands (INTEST, EXTEST, SAMPLE) on XC3S700AN and XC3S1400AN FPGAs	11.0		
T_{TMSTCK}	The time from the setup of a logic level at the TMS pin to the rising transition at the TCK pin		7.0	–	ns
Hold Times					
T_{TCKTDI}	The time from the rising transition at the TCK pin to the point when data is last held at the TDI pin	All functions except those shown below	0	–	ns
		Configuration commands (CFG_IN, ISC_PROGRAM)	2.0		
T_{TCKTMS}	The time from the rising transition at the TCK pin to the point when a logic level is last held at the TMS pin		0	–	ns
Clock Timing					
T_{CCH}	The High pulse width at the TCK pin	All functions except ISC_DNA command	5	–	ns
T_{CCL}	The Low pulse width at the TCK pin		5	–	ns
T_{CCHDNA}	The High pulse width at the TCK pin	During ISC_DNA command	10	10,000	ns
T_{CCLDNA}	The Low pulse width at the TCK pin		10	10,000	ns
F_{TCK}	Frequency of the TCK signal	All operations on XC3S50AN, XC3S200AN, and XC3S400AN FPGAs and for BYPASS or HIGHZ instructions on all FPGAs	0	33	MHz
		All operations on XC3S700AN and XC3S1400AN FPGAs, except for BYPASS or HIGHZ instructions		20	

Notes:

1. The numbers in this table are based on the operating conditions set forth in Table 10.
2. For details on JTAG, see Chapter 9, “JTAG Configuration Mode and Boundary-Scan” in UG332 *Spartan-3 Generation Configuration User Guide*.

TQG144 Footprint

Note: Pin 1 indicator in top-left corner and logo orientation.

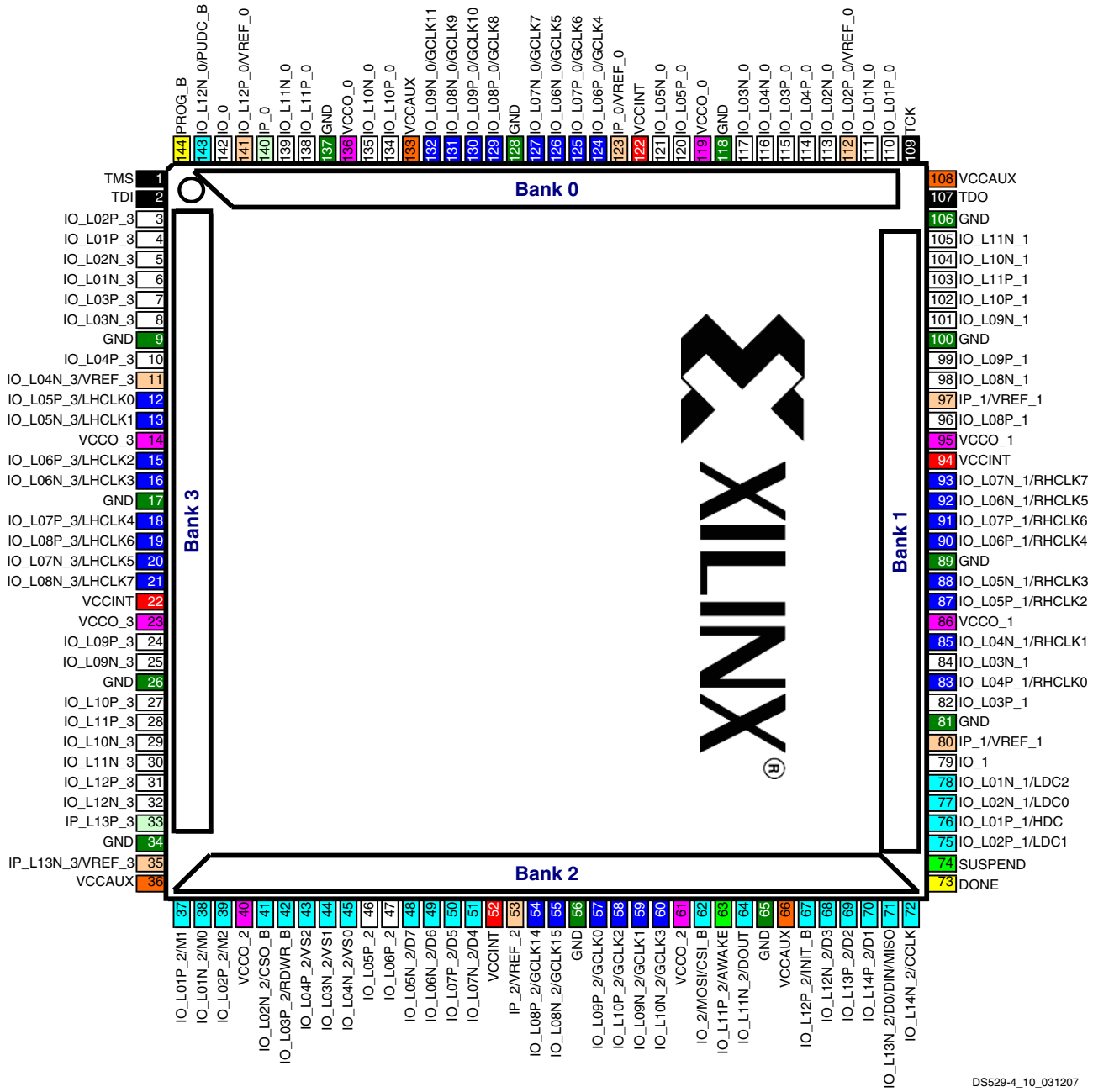

Figure 19: **XC3S50AN FPGA in TQG144 Package Footprint (Top View)**

42	**I/O:** Unrestricted, general-purpose user I/O	25	**DUAL:** Configuration pins, then possible user I/O	8	**VREF:** User I/O or input voltage reference for bank
2	**INPUT:** Unrestricted, general-purpose input pin	30	**CLK:** User I/O, input, or global buffer input	8	**VCCO:** Output voltage supply for bank
2	**CONFIG:** Dedicated configuration pins	4	**JTAG:** Dedicated JTAG port pins	4	**VCCINT:** Internal core supply voltage (+1.2V)
0	**N.C.:** Not connected	13	**GND:** Ground	4	**VCCAUX:** Auxiliary supply voltage
2	**SUSPEND:** Dedicated SUSPEND and dual-purpose AWAKE Power Management pins				

FTG256: 256-Ball Fine-Pitch, Thin Ball Grid Array

The 256-ball fine-pitch, thin ball grid array package, FTG256, supports the XC3S50AN, XC3S200AN, and XC3S400AN devices. Table 70 lists all the package pins for these devices. They are sorted by bank number and then by the pin name of the largest device. Pins that form a differential I/O pair appear together in the table. The differential I/O pairs that have different assignments between the XC3S50AN and the XC3S200AN or XC3S400AN are highlighted in light blue in Table 70. See Footprint Migration Differences, page 87 for additional information. The table also shows the pin number for each pin and the pin type (as defined in Table 62).

The footprints for the XC3S200AN and XC3S400AN in the FTG256 are identical. Figure 21 shows the common footprint for the XC3S200AN and XC3S400AN. The XC3S50AN footprint is compatible with the XC3S200AN and XC3S400AN, however, there are 51 unconnected balls (indicated as N.C. in Table 70).

Table 73 summarizes the XC3S50AN FPGA footprint migration differences for the FTG256 package.

The XC3S50AN does not support the address output pins for the byte-wide peripheral interface (BPI) configuration mode.

An electronic version of this package pinout table and footprint diagram is available for download from the Xilinx website at: www.xilinx.com/support/documentation/data_sheets/s3a_pin.zip.

Pinout Table

Table 70: **Spartan-3AN FTG256 Pinout (XC3S50AN, XC3S200AN, XC3S400AN)**

Bank	XC3S50AN Pin Name	XC3S200AN/XC3S400AN Pin Name	FTG256 Ball	Type
0	IO_L01N_0	IO_L01N_0	C13	I/O
0	IO_L01P_0	IO_L01P_0	D13	I/O
0	IO_L02N_0	IO_L02N_0	B14	I/O
0	IO_L02P_0/VREF_0	IO_L02P_0/VREF_0	B15	VREF
0	IO_L03N_0	IO_L03N_0	D11	I/O
0	IO_L03P_0	IO_L03P_0	C12	I/O
0	IO_L04N_0	IO_L04N_0	A13	I/O
0	IO_L04P_0	IO_L04P_0	A14	I/O
0	N.C.	IO_L05N_0	A12	I/O
0	IP_0	IO_L05P_0	B12	I/O
0	N.C.	IO_L06N_0/VREF_0	E10	VREF
0	N.C.	IO_L06P_0	D10	I/O
0	IO_L07N_0	IO_L07N_0	A11	I/O
0	IO_L07P_0	IO_L07P_0	C11	I/O
0	IO_L08N_0	IO_L08N_0	A10	I/O
0	IO_L08P_0	IO_L08P_0	B10	I/O
0	IO_L09N_0/GCLK5	IO_L09N_0/GCLK5	D9	GCLK
0	IO_L09P_0/GCLK4	IO_L09P_0/GCLK4	C10	GCLK
0	IO_L10N_0/GCLK7	IO_L10N_0/GCLK7	A9	GCLK
0	IO_L10P_0/GCLK6	IO_L10P_0/GCLK6	C9	GCLK
0	IO_L11N_0/GCLK9	IO_L11N_0/GCLK9	D8	GCLK
0	IO_L11P_0/GCLK8	IO_L11P_0/GCLK8	C8	GCLK
0	IO_L12N_0/GCLK11	IO_L12N_0/GCLK11	B8	GCLK
0	IO_L12P_0/GCLK10	IO_L12P_0/GCLK10	A8	GCLK
0	N.C.	IO_L13N_0	C7	I/O
0	N.C.	IO_L13P_0	A7	I/O

Table 70: **Spartan-3AN FTG256 Pinout (XC3S50AN, XC3S200AN, XC3S400AN) *(Cont'd)***

Bank	XC3S50AN Pin Name	XC3S200AN/XC3S400AN Pin Name	FTG256 Ball	Type
2	IP_2	IP_2	L7	INPUT
2	IP_2	IP_2	L8	INPUT
2	IP_2/VREF_2	IP_2/VREF_2	L9	VREF
2	IP_2/VREF_2	IP_2/VREF_2	L10	VREF
2	IP_2/VREF_2	IP_2/VREF_2	M7	VREF
2	IP_2/VREF_2	IP_2/VREF_2	M8	VREF
2	IP_2/VREF_2	IP_2/VREF_2	M11	VREF
2	IP_2/VREF_2	IP_2/VREF_2	N5	VREF
2	VCCO_2	VCCO_2	M9	VCCO
2	VCCO_2	VCCO_2	R4	VCCO
2	VCCO_2	VCCO_2	R8	VCCO
2	VCCO_2	VCCO_2	R12	VCCO
3	IO_L01N_3	IO_L01N_3	C1	I/O
3	IO_L01P_3	IO_L01P_3	C2	I/O
3	IO_L02N_3	IO_L02N_3	D3	I/O
3	IO_L02P_3	IO_L02P_3	D4	I/O
3	IO_L03N_3	IO_L03N_3	E1	I/O
3	IO_L03P_3	IO_L03P_3	D1	I/O
3	N.C.	IO_L05N_3	E2	I/O
3	N.C.	IO_L05P_3	E3	I/O
3	N.C.	IO_L07N_3	G4	I/O
3	N.C.	IO_L07P_3	F3	I/O
3	IO_L08N_3/VREF_3	IO_L08N_3/VREF_3	G1	VREF
3	IO_L08P_3	IO_L08P_3	F1	I/O
3	N.C.	IO_L09N_3	H4	I/O
3	N.C.	IO_L09P_3	G3	I/O
3	N.C.	IO_L10N_3	H5	I/O
3	N.C.	IO_L10P_3	H6	I/O
3	IO_L11N_3/LHCLK1	IO_L11N_3/LHCLK1	H1	LHCLK
3	IO_L11P_3/LHCLK0	IO_L11P_3/LHCLK0	G2	LHCLK
3	IO_L12N_3/IRDY2/LHCLK3	IO_L12N_3/IRDY2/LHCLK3	J3	LHCLK
3	IO_L12P_3/LHCLK2	IO_L12P_3/LHCLK2	H3	LHCLK
3	IO_L14N_3/LHCLK5	IO_L14N_3/LHCLK5	J1	LHCLK
3	IO_L14P_3/LHCLK4	IO_L14P_3/LHCLK4	J2	LHCLK
3	IO_L15N_3/LHCLK7	IO_L15N_3/LHCLK7	K1	LHCLK
3	IO_L15P_3/TRDY2/LHCLK6	IO_L15P_3/TRDY2/LHCLK6	K3	LHCLK
3	N.C.	IO_L16N_3	L2	I/O
3	N.C.	IO_L16P_3/VREF_3	L1	VREF
3	N.C.	IO_L17N_3	J6	I/O
3	N.C.	IO_L17P_3	J4	I/O

Table 73: **FTG256 XC3S50AN Footprint Migration/Differences *(Cont'd)***

FTG256 Ball	Bank	XC3S50AN	Migration	XC3S200AN or XC3S400AN
K13	1	N.C.	→	I/O
L1	3	N.C.	→	I/O/VREF
L2	3	N.C.	→	I/O
L3	3	N.C.	→	I/O
L4	3	N.C.	→	I/O
L13	1	N.C.	→	I/O
L14	1	N.C.	→	I/O
L16	1	N.C.	→	I/O
M3	3	N.C.	→	I/O
M10	2	N.C.	→	I/O
M13	1	N.C.	→	I/O
M14	1	N.C.	→	I/O/VREF
M15	1	N.C.	→	I/O
M16	1	N.C.	→	I/O
N7	2	N.C.	→	I/O
N10	2	N.C.	→	I/O
N12	2	N.C.	→	I/O
P6	2	N.C.	→	I/O
P13	2	N.C.	→	I/O
R7	2	N.C.	→	I/O
T7	2	N.C.	→	I/O
Number of Differences:			52	

Table 76: **Spartan-3AN FGG400 Pinout *(Cont'd)***

Bank	Pin Name	FGG400 Ball	Type
VCCAUX	TMS	E4	JTAG
VCCAUX	VCCAUX	A13	VCCAUX
VCCAUX	VCCAUX	E16	VCCAUX
VCCAUX	VCCAUX	H1	VCCAUX
VCCAUX	VCCAUX	K13	VCCAUX
VCCAUX	VCCAUX	L8	VCCAUX
VCCAUX	VCCAUX	N20	VCCAUX
VCCAUX	VCCAUX	T5	VCCAUX
VCCAUX	VCCAUX	Y8	VCCAUX
VCCINT	VCCINT	J10	VCCINT
VCCINT	VCCINT	J12	VCCINT
VCCINT	VCCINT	K9	VCCINT
VCCINT	VCCINT	K11	VCCINT
VCCINT	VCCINT	L10	VCCINT
VCCINT	VCCINT	L12	VCCINT
VCCINT	VCCINT	M9	VCCINT
VCCINT	VCCINT	M11	VCCINT
VCCINT	VCCINT	N10	VCCINT

User I/Os by Bank

Table 77 indicates how the 311 available user-I/O pins are distributed between the four I/O banks on the FGG400 package. The AWAKE pin is counted as a dual-purpose I/O.

Table 77: **User I/Os Per Bank for the XC3S400AN in the FGG400 Package**

Package Edge	I/O Bank	Maximum I/Os	All Possible I/O Pins by Type				
			I/O	INPUT	DUAL	VREF	CLK
Top	0	77	50	12	1	6	8
Right	1	79	21	12	30	8	8
Bottom	2	76	35	6	21	6	8
Left	3	79	49	16	0	6	8
Total		**311**	**155**	**46**	**52**	**26**	**32**

Footprint Migration Differences

The XC3S400AN is the only Spartan-3AN FPGA offered in the FGG400 package.

The XC3S400AN FPGA is pin compatible with the Spartan-3A XC3S400A FPGA in the FG(G)400 package, although the Spartan-3A FPGA requires an external configuration source.

Table 82: **Spartan-3AN FGG676 Pinout *(Cont'd)***

Bank	Pin Name	FGG676 Ball	Type
3	IO_L30N_3	N4	I/O
3	IO_L30P_3	N5	I/O
3	IO_L31N_3	N2	I/O
3	IO_L31P_3	N1	I/O
3	IO_L32N_3/LHCLK1	N7	LHCLK
3	IO_L32P_3/LHCLK0	N6	LHCLK
3	IO_L33N_3/IRDY2/LHCLK3	P2	LHCLK
3	IO_L33P_3/LHCLK2	P1	LHCLK
3	IO_L34N_3/LHCLK5	P3	LHCLK
3	IO_L34P_3/LHCLK4	P4	LHCLK
3	IO_L35N_3/LHCLK7	P10	LHCLK
3	IO_L35P_3/TRDY2/LHCLK6	N9	LHCLK
3	IO_L36N_3	R2	I/O
3	IO_L36P_3/VREF_3	R1	VREF
3	IO_L37N_3	R4	I/O
3	IO_L37P_3	R3	I/O
3	IO_L38N_3	T4	I/O
3	IO_L38P_3	T3	I/O
3	IO_L39N_3	P6	I/O
3	IO_L39P_3	P7	I/O
3	IO_L40N_3	R6	I/O
3	IO_L40P_3	R5	I/O
3	IO_L41N_3	P9	I/O
3	IO_L41P_3	P8	I/O
3	IO_L42N_3	U4	I/O
3	IO_L42P_3	T5	I/O
3	IO_L43N_3	R9	I/O
3	IO_L43P_3/VREF_3	R10	VREF
3	IO_L44N_3	U2	I/O
3	IO_L44P_3	U1	I/O
3	IO_L45N_3	R7	I/O
3	IO_L45P_3	R8	I/O
3	IO_L47N_3	V2	I/O
3	IO_L47P_3	V1	I/O
3	IO_L48N_3	T9	I/O
3	IO_L48P_3	T10	I/O
3	IO_L49N_3	V5	I/O
3	IO_L49P_3	U5	I/O
3	IO_L51N_3	U6	I/O
3	IO_L51P_3	T7	I/O

Table 82: **Spartan-3AN FGG676 Pinout *(Cont'd)***

Bank	Pin Name	FGG676 Ball	Type
3	IO_L52N_3	W4	I/O
3	IO_L52P_3	W3	I/O
3	IO_L53N_3	Y2	I/O
3	IO_L53P_3	Y1	I/O
3	IO_L55N_3	AA3	I/O
3	IO_L55P_3	AA2	I/O
3	IO_L56N_3	U8	I/O
3	IO_L56P_3	U7	I/O
3	IO_L57N_3	Y6	I/O
3	IO_L57P_3	Y5	I/O
3	IO_L59N_3	V6	I/O
3	IO_L59P_3	V7	I/O
3	IO_L60N_3	AC1	I/O
3	IO_L60P_3	AB1	I/O
3	IO_L61N_3	V8	I/O
3	IO_L61P_3	U9	I/O
3	IO_L63N_3	W6	I/O
3	IO_L63P_3	W7	I/O
3	IO_L64N_3	AC3	I/O
3	IO_L64P_3	AC2	I/O
3	IO_L65N_3	AD2	I/O
3	IO_L65P_3	AD1	I/O
3	IP_L04N_3/VREF_3	C1	VREF
3	IP_L04P_3	C2	INPUT
3	IP_L08N_3	D1	INPUT
3	IP_L08P_3	D2	INPUT
3	IP_L12N_3/VREF_3	H4	VREF
3	IP_L12P_3	G5	INPUT
3	IP_L16N_3	G1	INPUT
3	IP_L16P_3	G2	INPUT
3	IP_L20N_3/VREF_3	J2	VREF
3	IP_L20P_3	J3	INPUT
3	IP_L24N_3	K1	INPUT
3	IP_L24P_3	J1	INPUT
3	IP_L46N_3	V4	INPUT
3	IP_L46P_3	U3	INPUT
3	IP_L50N_3/VREF_3	W2	VREF
3	IP_L50P_3	W1	INPUT
3	IP_L54N_3	Y4	INPUT
3	IP_L54P_3	Y3	INPUT

Table 82: **Spartan-3AN FGG676 Pinout *(Cont'd)***

Bank	Pin Name	FGG676 Ball	Type
3	IP_L58N_3/VREF_3	AA5	VREF
3	IP_L58P_3	AA4	INPUT
3	IP_L62N_3	AB4	INPUT
3	IP_L62P_3	AB3	INPUT
3	IP_L66N_3/VREF_3	AE2	VREF
3	IP_L66P_3	AE1	INPUT
3	VCCO_3	AB2	VCCO
3	VCCO_3	E2	VCCO
3	VCCO_3	H5	VCCO
3	VCCO_3	L2	VCCO
3	VCCO_3	L8	VCCO
3	VCCO_3	P5	VCCO
3	VCCO_3	T2	VCCO
3	VCCO_3	T8	VCCO
3	VCCO_3	W5	VCCO
GND	GND	A1	GND
GND	GND	A6	GND
GND	GND	A11	GND
GND	GND	A16	GND
GND	GND	A21	GND
GND	GND	A26	GND
GND	GND	AA1	GND
GND	GND	AA6	GND
GND	GND	AA11	GND
GND	GND	AA16	GND
GND	GND	AA21	GND
GND	GND	AA26	GND
GND	GND	AD3	GND
GND	GND	AD8	GND
GND	GND	AD13	GND
GND	GND	AD18	GND
GND	GND	AD24	GND
GND	GND	AF1	GND
GND	GND	AF6	GND
GND	GND	AF11	GND
GND	GND	AF16	GND
GND	GND	AF21	GND
GND	GND	AF26	GND
GND	GND	C3	GND
GND	GND	C9	GND

Table 82: **Spartan-3AN FGG676 Pinout *(Cont'd)***

Bank	Pin Name	FGG676 Ball	Type
GND	GND	C14	GND
GND	GND	C19	GND
GND	GND	C24	GND
GND	GND	F1	GND
GND	GND	F6	GND
GND	GND	F11	GND
GND	GND	F16	GND
GND	GND	F21	GND
GND	GND	F26	GND
GND	GND	H3	GND
GND	GND	H8	GND
GND	GND	H14	GND
GND	GND	H19	GND
GND	GND	J24	GND
GND	GND	K10	GND
GND	GND	K17	GND
GND	GND	L1	GND
GND	GND	L6	GND
GND	GND	L11	GND
GND	GND	L13	GND
GND	GND	L15	GND
GND	GND	L21	GND
GND	GND	L26	GND
GND	GND	M12	GND
GND	GND	M14	GND
GND	GND	M16	GND
GND	GND	N3	GND
GND	GND	N8	GND
GND	GND	N11	GND
GND	GND	N15	GND
GND	GND	P12	GND
GND	GND	P16	GND
GND	GND	P19	GND
GND	GND	P24	GND
GND	GND	R11	GND
GND	GND	R13	GND
GND	GND	R15	GND
GND	GND	T1	GND
GND	GND	T6	GND
GND	GND	T12	GND

Right Half of FGG676 Package (Top View)

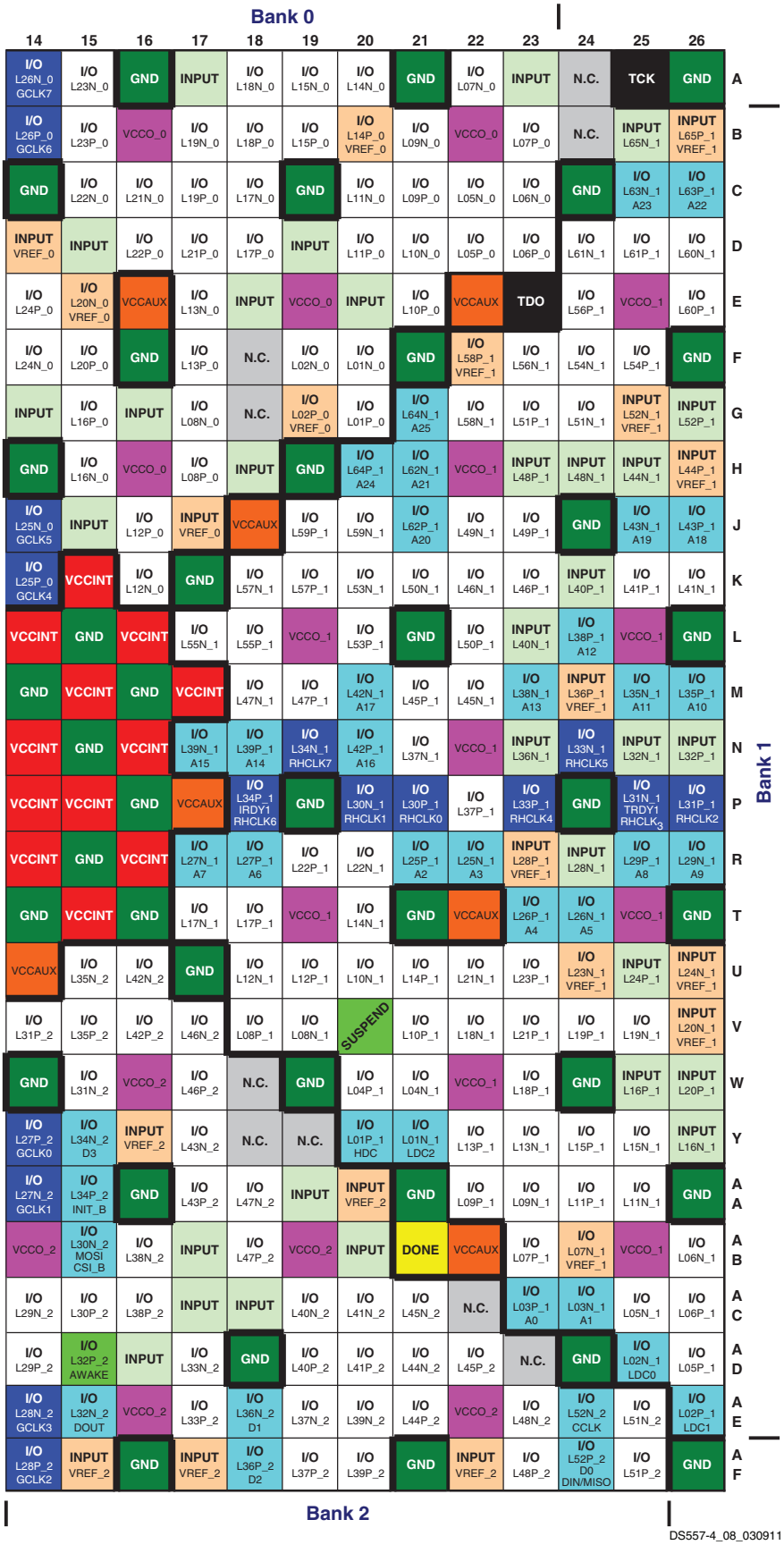

Figure 24: **FGG676 Package Footprint (Top View)**